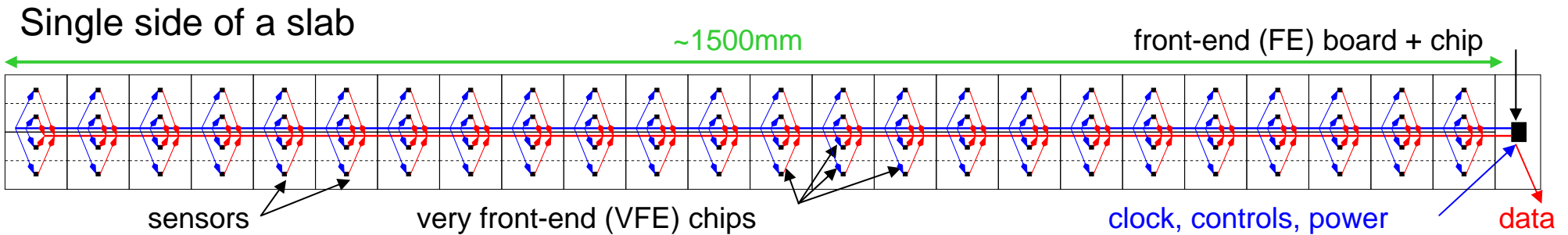


Study of 1.5m data paths along CALICE slabs

- the ‘problem’ & its scale
- technology and architecture choices
- test-slab design options
- current status
- outlook and plans

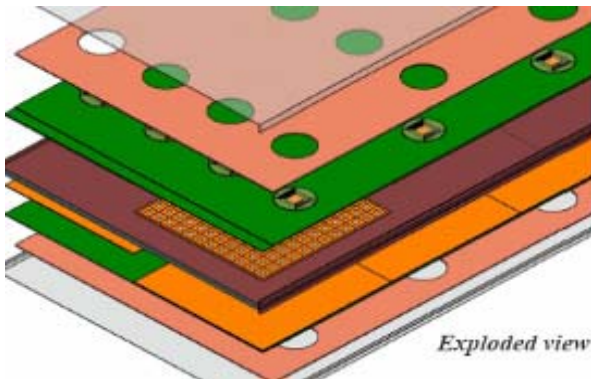
The 'problem' & its scale



- Paths between VFEs and FE:
 - Clock and Control to VFE chips
 - Data from VFEs to FE chip
 - Readout Token and Monitoring

<i>sensor size</i>	<i>60x60mm</i>
<i>pad size</i>	<i>5x5mm</i>
<i>typical slab size</i>	<i>120x1440mm</i>
<i># channels/slab</i>	<i>6912</i>
<i>VFE chip channel count</i>	<i>72</i>
<i># VFE chips/slab</i>	<i>96</i>

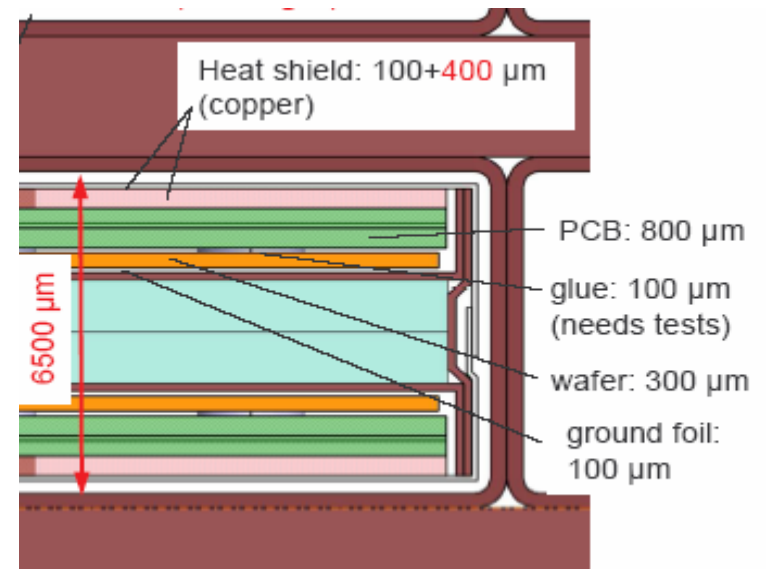
Slab design



- Constraints on data paths:
 - Limited space (800 μm PCB thickness)
 - Tight power budget (~ 0 mW)
 - Long slabs (~ 1.6 m)

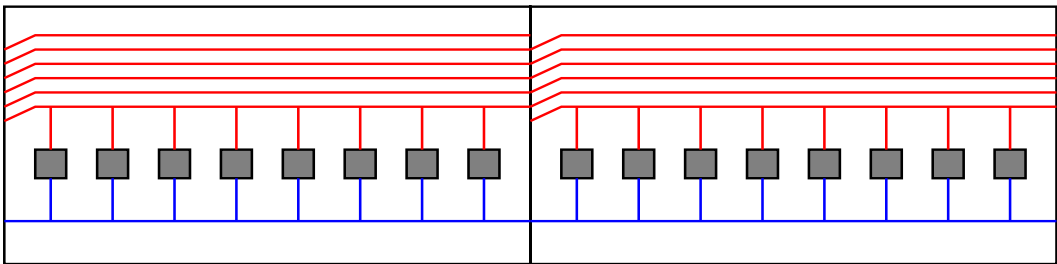
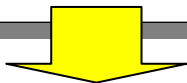
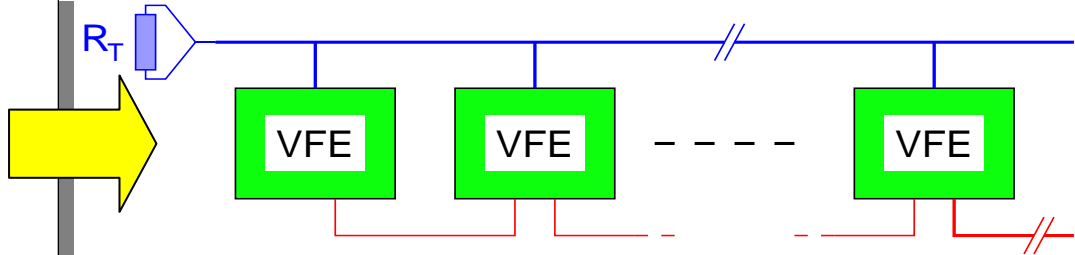
Technology choices:

- VFE chip on board: build slab in segments to conserve yield
- Introduces a joint between PCBs...
- CMOS signalling where possible for low power consumption



Signal distro & readout architecture

- ❑ Signal routing options on a panel:
 - common lines vs. point-to-point
- ❑ Signal routing along a full slab:
 - slab-wide or per-panel distribution



- Fast links at low duty cycle are power efficient
- Power-speed tradeoff governed by transmission line characteristics

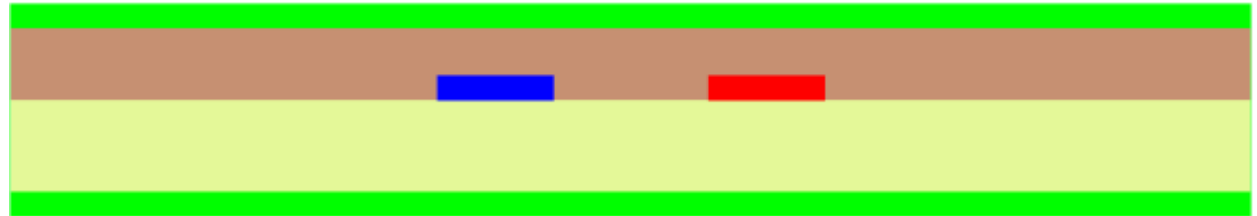
¿ how much redundancy should be built in ?

¿ should clock & data be combined for increased reliability ?

PCB traces = Transmission Lines

Run ACTL simulation with following geometry:

- 64 μ m (2.5 thou) PCB thickness
- 50 μ m (2.0 thou) pre-preg thickness
- 17 μ m (0.7 thou) = 0.5 oz Cu layer



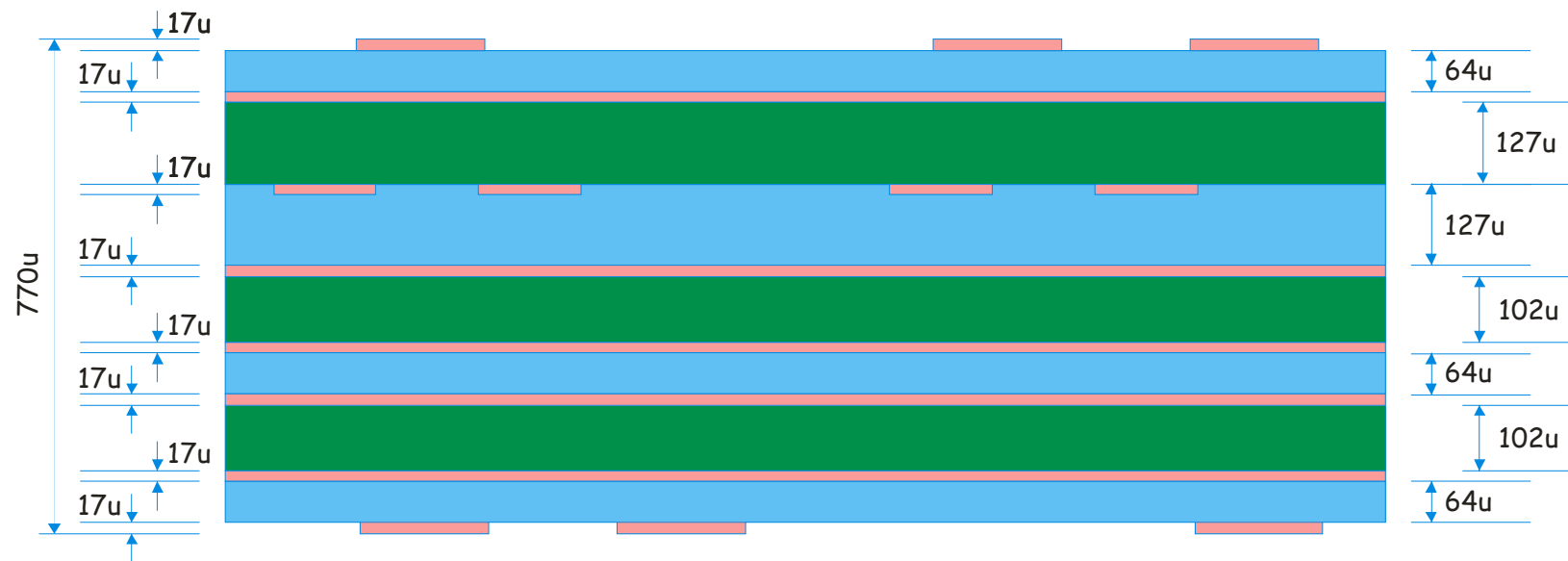
Trace width (μ m)	C0 (pF/m)	Z0 (Ohm)
200	373	16.5
150	305	20.3
100	229	27.1
75	± 160	32.8



Low Z and high C makes
CMOS noisy and power-
hungry

Slab Panel PCB board build

- Recent revision of Slab PCB thickness = 800um
- Expected thickness ~ 770um + resist + text
- Top, Bottom and Differential Signal layers
- 5 Power and Ground Planes



Estimated data readout speed

- readout of **all channels** for **all BX'es** results in **unrealistically** high data rates

χ Gbps/chip

- duty cycle/buffering reduces rate **200x**

$\chi\chi\chi$ Mbps

- readout speed determined by data reduction through **zero-suppression**

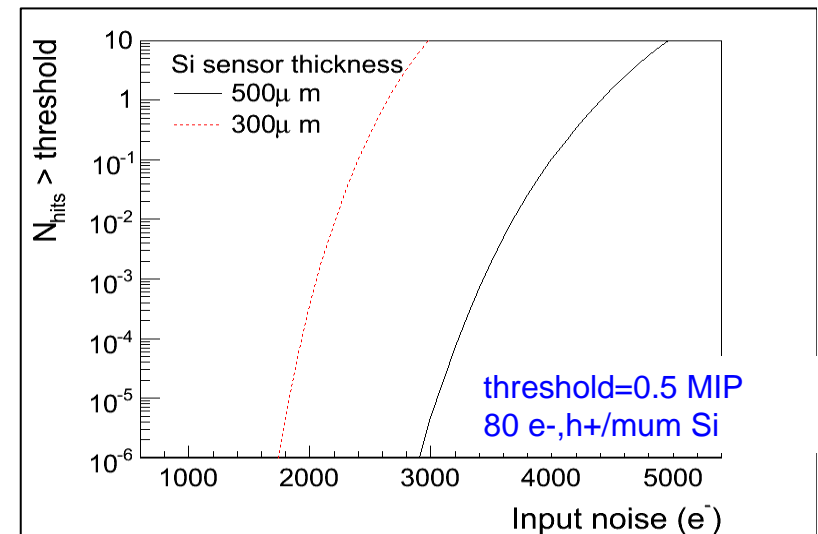
$\chi\text{-}\chi\chi\chi$ Mbps

- **ultimate** case: few events/chip/Bx train (still dominated by noise...)

χ Mbps

Assumptions:

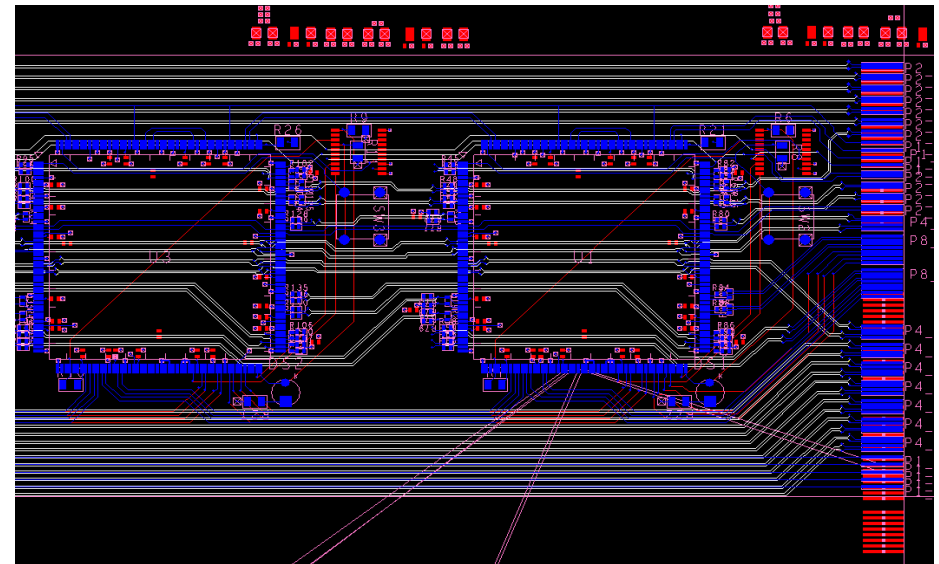
- 72 channels/chip
- 5k events/bx train
- 1 ms train length
- 5 Hz repetition rate



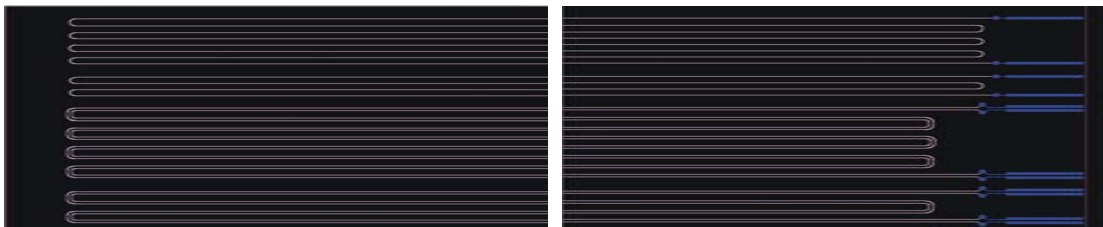
Slab model

Build a slab model to test the many variables

- FPGAs instead of VFE chips
- 1 FPGA mimics 2 VFE chips
- HCAL in VHDL serves as VFE

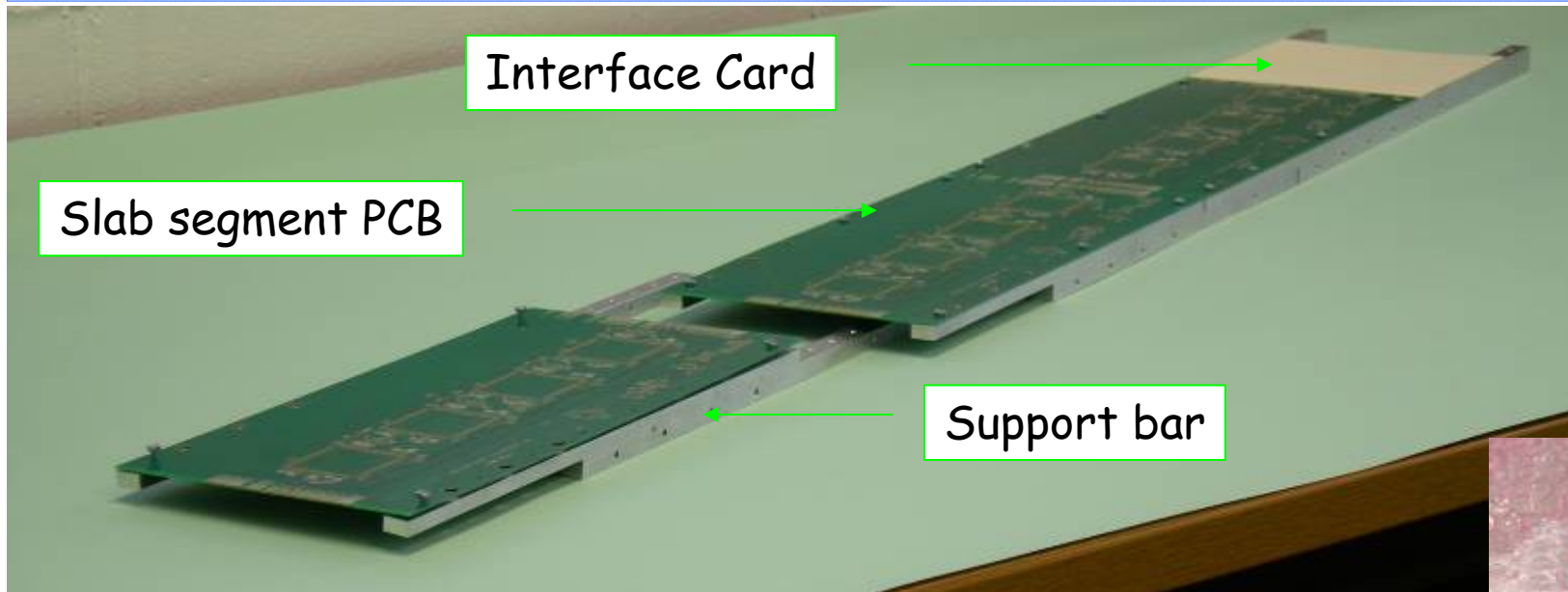


~ 240mm



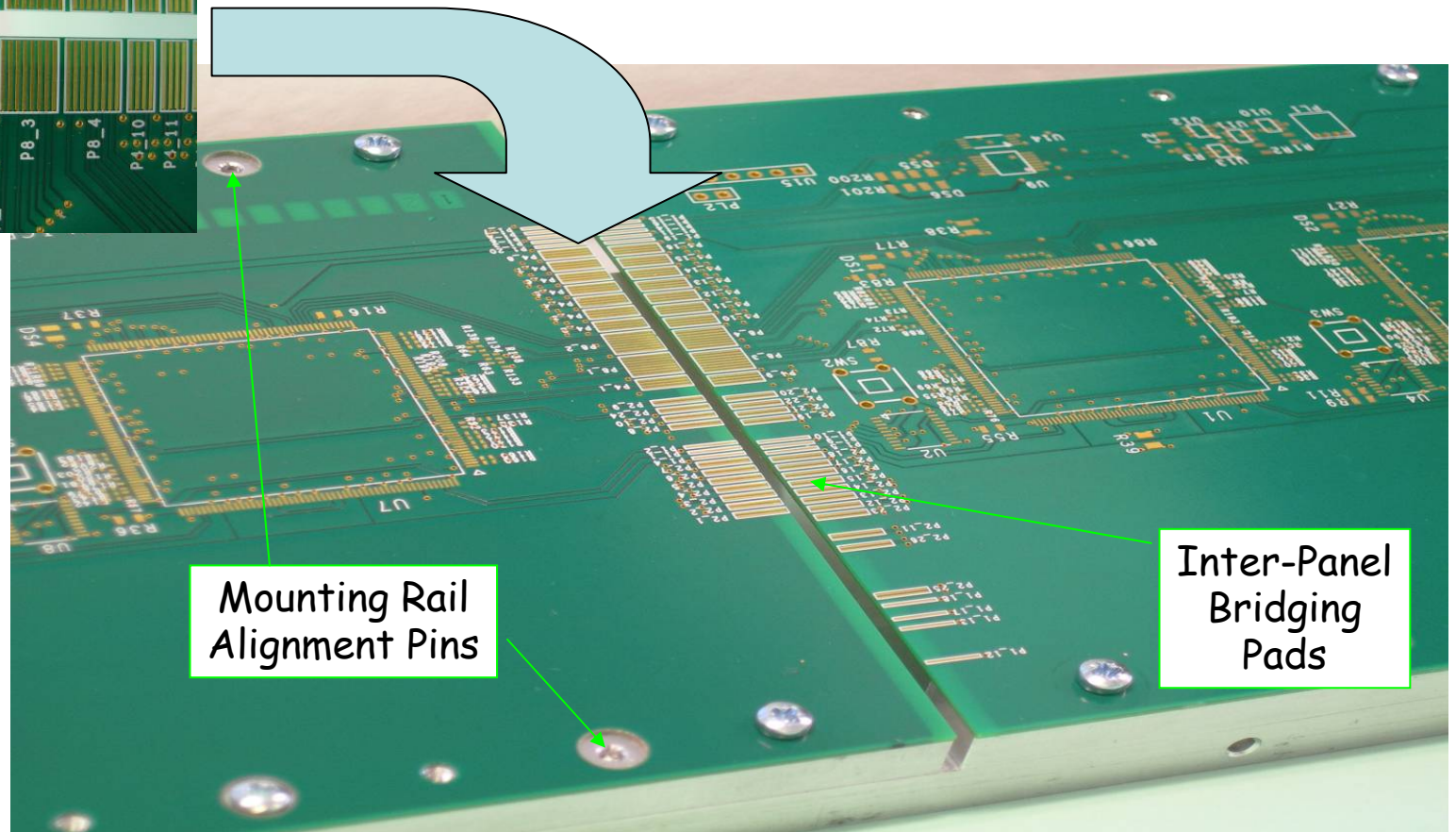
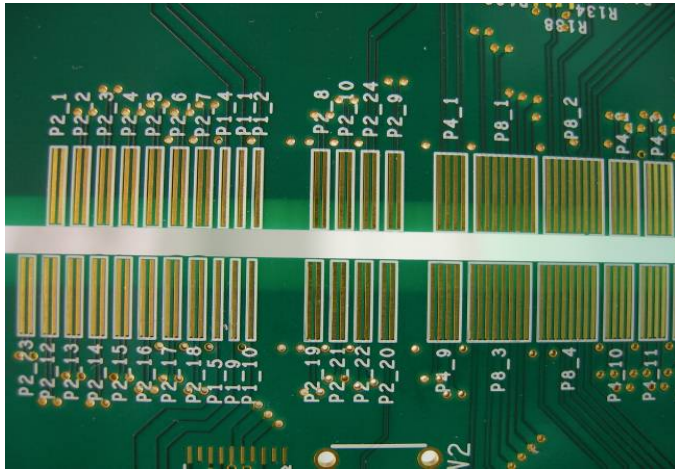
- Many signal distro/routing options incorporated in PCB
- Many output standards and speeds supported by FPGA
- Includes long, folded lines for measurements on transmission lines

Slab model: current status



- 10 PCBs manufactured
- PCB support bars for slab assembly
- 1 PCB populated and powered:
initial tests (JTAG chain, programming of devices)

Panel PCB interconnects

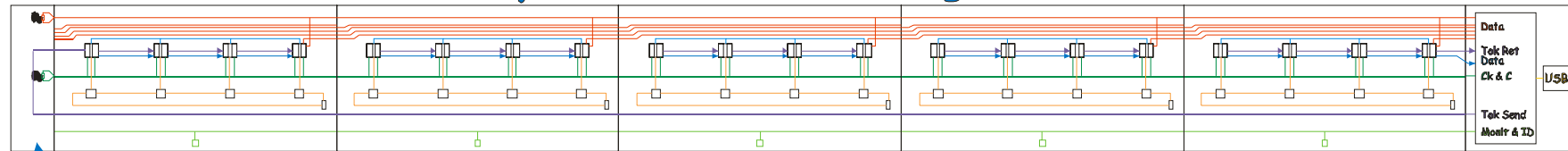


Mounting Rail
Alignment Pins

Inter-Panel
Bridging
Pads

The ends of the slab

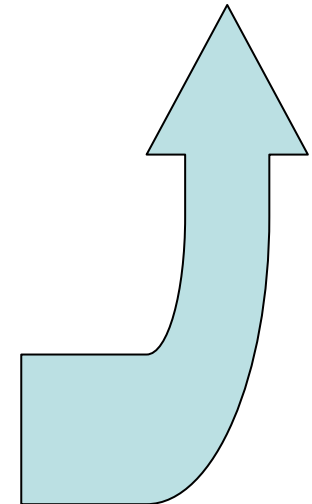
Multiple Test Panels forming a Test Slab



Terminator
Panel

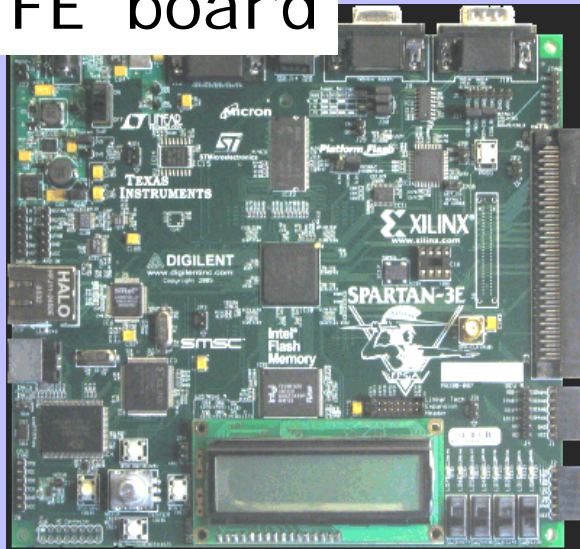
End-of-slab (FE) task:

- data collection from pVFE chips
- data buffering
- clock distribution: 40MHz & 1MHz
- control signals: reset, initialisation
- JTAG programming chain
- power distribution
- signals for tests & measurements (BER)
- communication with outside world

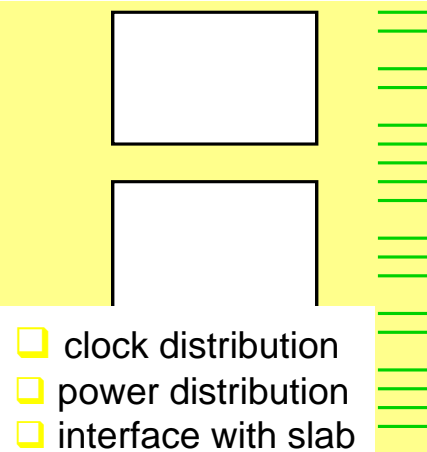


Test slab setup

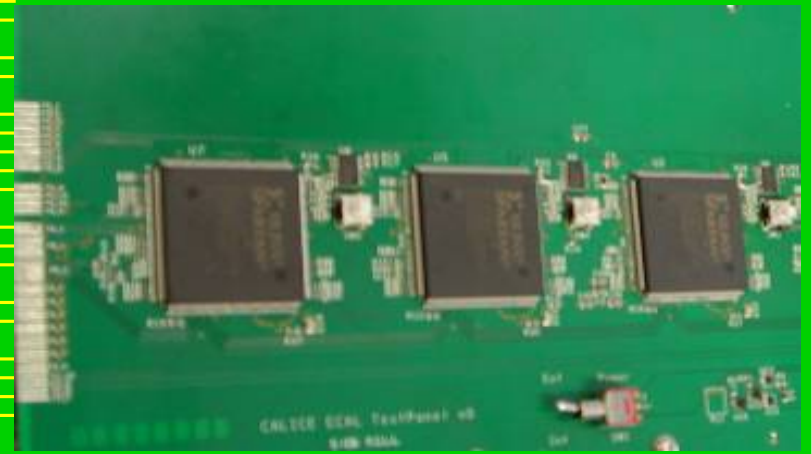
FE board



intermediate board



slab panel 0



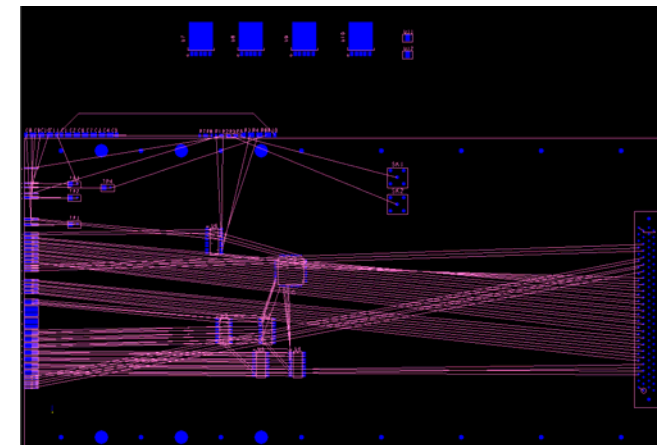
- clock generation
- control signals (token, etc.)
- data reception & buffering
- interface with outside world

Digilent starter kit serves as FE board:

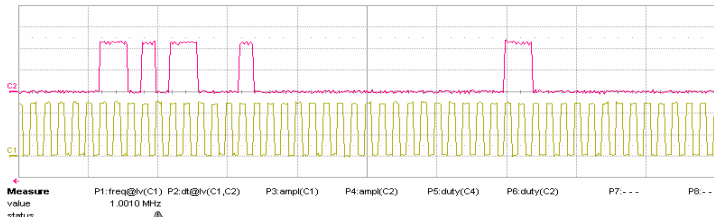
- Xilinx Spartan 3E-500 FPGA
 - supports many IO standards over large speed range
- large user connector (~40x I/O pins up to 100MHz)
- 32MB SDRAM
- Ethernet 10/100 PHY
- USB-JTAG programming

Test slab status

- Slab panels: 1 panel populated and being tested
not all panels are to be equipped with FPGAs
- Intermediate board: schematics, PCB design well under way
- Firmware for pVFE FPGAs is ready
'v.0.99'
- Essentials for FE firmware available
clock manager, deserialiser, data buffer

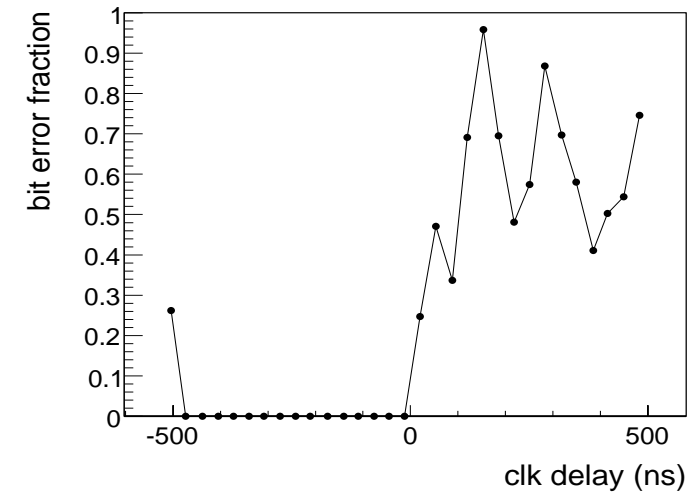
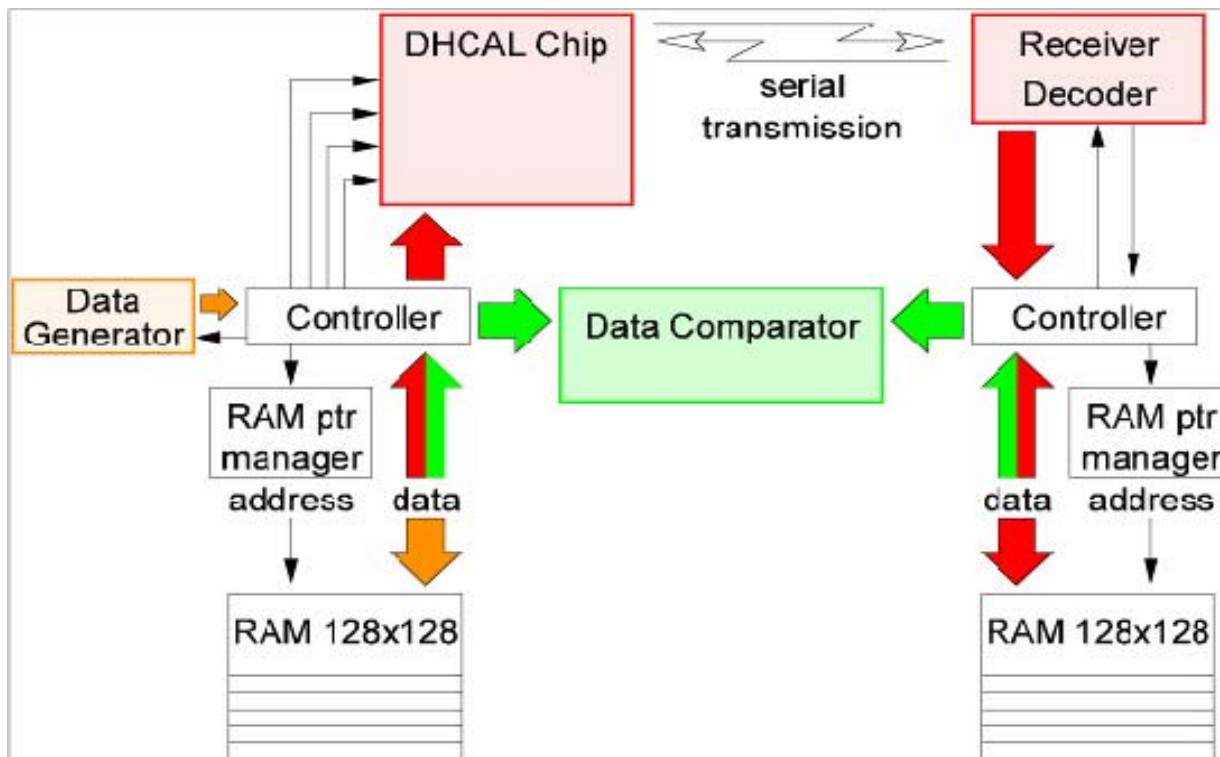


pVFE and FE firmware: BER test



First Bit Error Rate (BER) test:

- ✓ all logic in single FPGA
- ✓ separated Tx/Rx blocks
- ✓ signals routed through external wires



The expected 'bathtub' plot looks a bit ragged, but it has a clear bottom –in the wrong place?

Test & measurement programme

- BER tests on panels with multiple pVFEs
- different clocking & readout schemes
- other options: clock+data encoding, redundancy routing, etc.
- folded traces: transmission characteristics
- determine data transmission speed limits



Outlook & Plans

- Complete test slab programme
 - Optimise PCB wrt the data rate requirements
 - Determine ultimate DAQ performance requirements using test slab PCB max. throughput figures
- Contribute to the Calice slab design by providing feedback –where and if appropriate
 - Make our components (design & test tools) available to the Calice programme
- Start design study of FE board:
 - possibly including a redesigned intermediate board
 - modular design for maximum flexibility